# **<u>MOSFET</u> – Power, Dual N-Channel 40 V. 11.5 mΩ. 36 A**

#### Features

- Small Footprint (5x6 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- NVMFD5C470NLWF Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant



## **ON Semiconductor®**

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V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
40 V	11.5 m $\Omega$ @ 10 V	00.4
40 V	17.8 mΩ @ 4.5 V	36 A

MAXIMUM RATINGS	(T <sub>J</sub> = 25°	C unless otherv	vise noted)		
Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	40	V
Gate-to-Source Voltage	Gate-to-Source Voltage			±20	V
Continuous Drain	Steady	$T_{C} = 25^{\circ}C$	I <sub>D</sub>	36	А
Current R <sub>θJC</sub> (Notes 1, 2, 3)		T <sub>C</sub> = 100°C		25	
Power Dissipation	State	T <sub>C</sub> = 25°C	PD	28	W
$R_{\theta JC}$ (Notes 1, 2)		T <sub>C</sub> = 100°C		14	1
Continuous Drain Current R <sub>θJA</sub> (Notes 1, 2, 3)	Steady State	$T_A = 25^{\circ}C$	I <sub>D</sub>	11	А
		$T_A = 100^{\circ}C$		8.0	
Power Dissipation		T <sub>A</sub> = 25°C	PD	3.0	W
R <sub>θJA</sub> (Notes 1, 2)		T <sub>A</sub> = 100°C		1.5	1
Pulsed Drain Current	$T_A = 25^{\circ}C$ , $t_p = 10 \ \mu s$		I <sub>DM</sub>	110	А
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	–55 to +175	°C
Source Current (Body Diode)			I <sub>S</sub>	23	А
Single Pulse Drain-to-Source Avalanche Energy (T <sub>J</sub> = 25°C, $I_{L(pk)}$ = 2 A)			E <sub>AS</sub>	49	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C
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Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

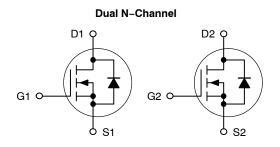
#### THERMAL RESISTANCE MAXIMUM RATINGS

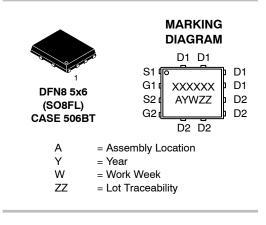
Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	5.3	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	49	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.

3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.





## **ORDERING INFORMATION**

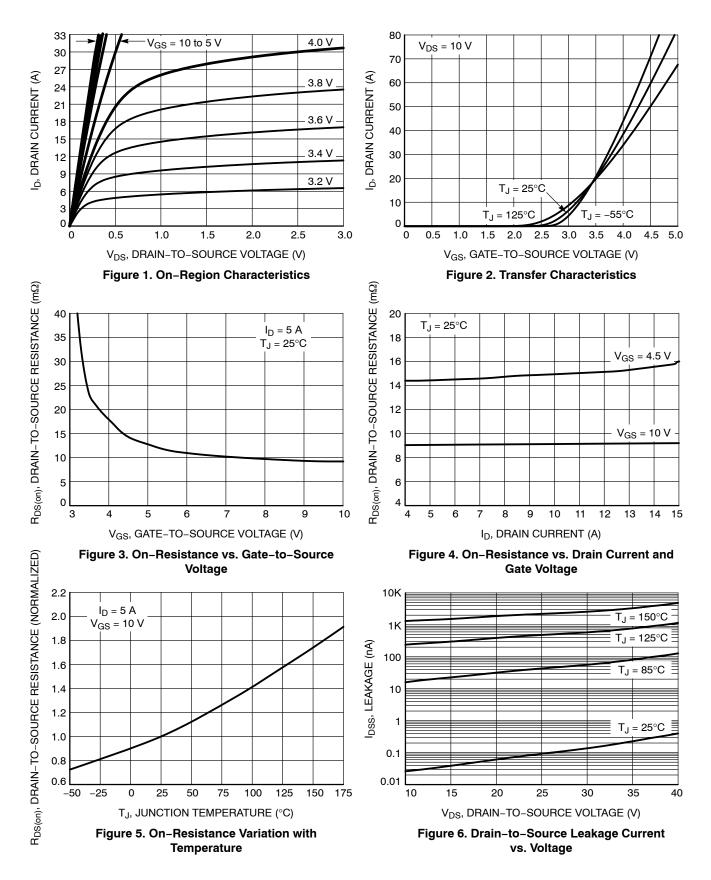
See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

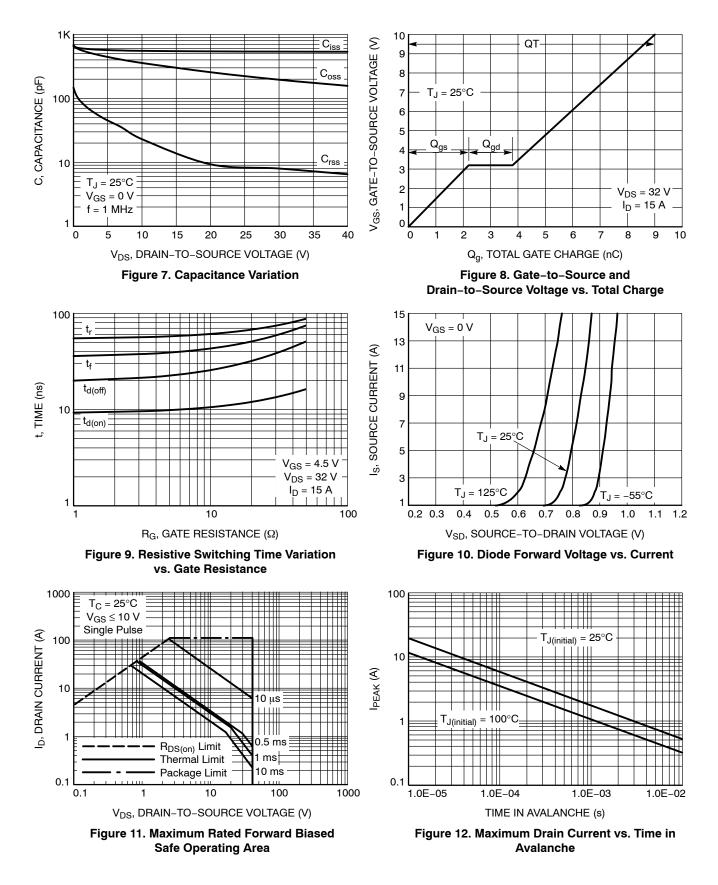
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, I <sub>D</sub> = 250 $\mu$ A		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>				24		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 40 V	T <sub>J</sub> = 25 °C			10	
			T <sub>J</sub> = 125°C			100	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 20 V				100	nA
ON CHARACTERISTICS (Note 4)					•		
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D$	= 20 μA	1.2		2.2	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-4.5		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 5 A		9.2	11.5	_
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 5 A		14.6	17.8	mΩ
Forward Transconductance	9 <sub>FS</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 15 A			30		S
CHARGES, CAPACITANCES & GATE RESIS	TANCE			-			
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 25 V			590		
Output Capacitance	C <sub>OSS</sub>				200		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				8.0		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS}$ = 4.5 V, $V_{DS}$ = 32 V; $I_{D}$ = 15 A			4.0		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 32 V; $I_{D}$ = 15 A			9.0		
Threshold Gate Charge	Q <sub>G(TH)</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 32 V; I <sub>D</sub> = 15 A			1.1		nC
Gate-to-Source Charge	Q <sub>GS</sub>				2.2		
Gate-to-Drain Charge	Q <sub>GD</sub>				1.6		
Plateau Voltage	V <sub>GP</sub>				3.2		V
SWITCHING CHARACTERISTICS (Note 5)				-			
Turn-On Delay Time	t <sub>d(ON)</sub>				9.3		
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub>	s = 32 V.		55		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$I_D = 15 \text{ A}, \text{ R}_G = 1.0 \Omega$			20		- ns
Fall Time	t <sub>f</sub>				36		
DRAIN-SOURCE DIODE CHARACTERISTIC	s				•		
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$		0.87	1.2	
		$I_{\rm S} = 15  \text{A}$ $T_{\rm J} = 125^{\circ} \text{C}$			0.76		V
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dIS/dt = 100 A/µs, I <sub>S</sub> = 15 A			20		
Charge Time	t <sub>a</sub>				10		ns
Discharge Time	t <sub>b</sub>				10		1
Reverse Recovery Charge	Q <sub>RR</sub>				9		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.
4. Pulse Test: pulse width ≤ 300 µs, duty cycle ≤ 2%.
5. Switching characteristics are independent of operating junction temperatures.

### **TYPICAL CHARACTERISTICS**



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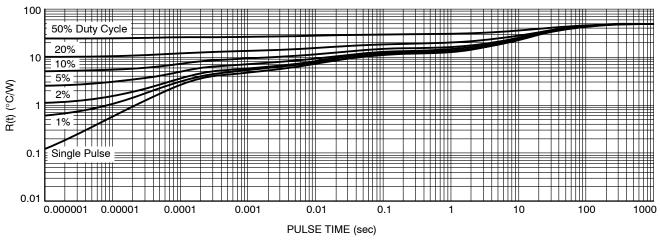


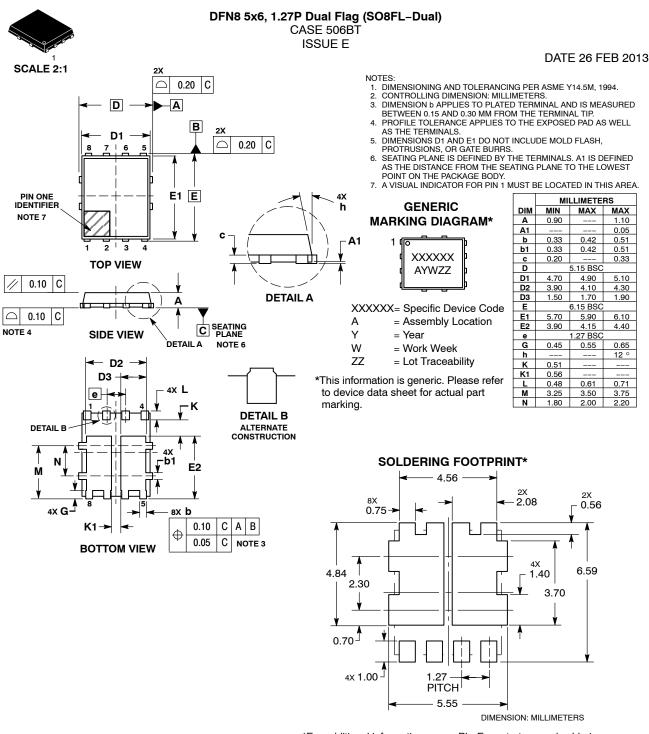
Figure 13. Thermal Response

#### **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NVMFD5C470NLT1G	5C470L	DFN8 (Pb–Free)	1500 / Tape & Reel
NVMFD5C470NLWFT1G	470LWF	DFN8 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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